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Application/Control No.

10/083,991

Applicant(s)/Patent Under
Reexamination
CHANG ET AL.

Examiner

Stanetta D. Isaac

Art Unit

2812

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6365523	04-2002	Jang et al.	
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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